

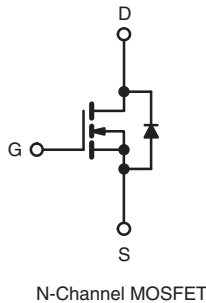
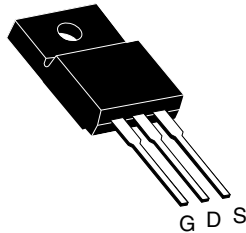


**THE DATASHEET OF  
SIHF22N60S-E3**



## S Series Power MOSFET

| PRODUCT SUMMARY                         |                 |       |
|---|-----------------|-------|
| $V_{DS}$ at $T_J$ max. (V)              | 650             |       |
| $R_{DS(on)}$ max. at 25 °C ( $\Omega$ ) | $V_{GS} = 10$ V | 0.190 |
| $Q_g$ max. (nC)                         | 98              |       |
| $Q_{gs}$ (nC)                           | 17              |       |
| $Q_{gd}$ (nC)                           | 25              |       |
| Configuration                           | Single          |       |

**TO-220 FULLPAK**


### FEATURES

- Generation one
- High  $E_{AR}$  capability
- Lower figure-of-merit  $R_{on} \times Q_g$
- 100 % avalanche tested
- Ultra low  $R_{on}$
- $dV/dt$  ruggedness
- Ultra low gate charge ( $Q_g$ )
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)


**RoHS\***  
Available

### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details.

### APPLICATIONS

- PFC power supply stages
- Hard switching topologies
- Solar inverters
- UPS
- Motor control
- Lighting
- Server telecom


| ORDERING INFORMATION |                |
|----------------------|----------------|
| Package              | TO-220 FULLPAK |
| Lead (Pb)-free       | SiHF22N60S-E3  |

| ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted |                  |                |      |      |
|--|------------------|----------------|------|------|
| PARAMETER  | SYMBOL           | LIMIT          | UNIT |      |
| Drain-Source Voltage   | $V_{DS}$         | 600            | V    |      |
| Gate-Source Voltage  | $V_{GS}$         | $\pm 30$       |      |      |
| Continuous Drain Current <sup>a</sup>                          | $V_{GS}$ at 10 V | $T_C = 25$ °C  | 22   | A    |
|  |                  | $T_C = 100$ °C | 13   |      |
| Pulsed Drain Current <sup>b</sup>                              | $I_{DM}$         | 65             |      |      |
| Linear Derating Factor   |                  | 2              | W/°C |      |
| Single Pulse Avalanche Energy <sup>c</sup>                     | $E_{AS}$         | 690            | mJ   |      |
| Repetitive Avalanche Energy <sup>b</sup>                       | $E_{AR}$         | 25             |      |      |
| Maximum Power Dissipation                                      | $P_D$            | 250            | W    |      |
| Drain-Source Voltage Slope                                     | $dV/dt$          | $T_J = 125$ °C | 37   | V/ns |
| Reverse Diode $dV/dt$ <sup>e</sup>                             |                  | 5.3            |      |      |
| Operating Junction and Storage Temperature Range               | $T_J, T_{stg}$   | -55 to +150    | °C   |      |
| Soldering Recommendations (Peak Temperature) <sup>d</sup>      | for 10 s         | 300            |      |      |

### Notes

- Limited by maximum junction temperature.
- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 28.2$  mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 7$  A.
- 1.6 mm from case.
- $I_{SD} \leq I_D$ ,  $dI/dt = 100$  A/ $\mu$ s, starting  $T_J = 25$  °C.

| THERMAL RESISTANCE RATINGS       |            |      |      |      |
|----------------------------------|------------|------|------|------|
| PARAMETER                        | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient      | $R_{thJA}$ | -    | 65   | °C/W |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$ | -    | 3.4  |      |

| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                             |   |   |      |       |           |               |
|--|-----------------------------|---|---|------|-------|-----------|---------------|
| PARAMETER  | SYMBOL                      | TEST CONDITIONS   |   | MIN. | TYP.  | MAX.      | UNIT          |
| <b>Static</b>  |                             |   |   |      |       |           |               |
| Drain-Source Breakdown Voltage   | $V_{DS}$                    | $V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$  |   | 600  | -     | -         | V             |
| $V_{DS}$ Temperature Coefficient   | $\Delta V_{DS}/T_J$         | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}$   |   | -    | 0.70  | -         | V/°C          |
| Gate-Source Threshold Voltage (N)  | $V_{GS(th)}$                | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$   |   | 2.0  | -     | 4.0       | V             |
| Gate-Source Leakage  | $I_{GSS}$                   | $V_{GS} = \pm 20\text{ V}$  |   | -    | -     | $\pm 100$ | nA            |
|  |                             | $V_{GS} = \pm 30\text{ V}$  |   | -    | -     | $\pm 1$   | $\mu\text{A}$ |
| Zero Gate Voltage Drain Current  | $I_{DSS}$                   | $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$  |   | -    | -     | 5         | $\mu\text{A}$ |
|  |                             | $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}, T_J = 150\text{ }^\circ\text{C}$                         |   | -    | -     | 100       |               |
| Drain-Source On-State Resistance   | $R_{DS(on)}$                | $V_{GS} = 10\text{ V}$  | $I_D = 11\text{ A}$   | -    | 0.160 | 0.190     | $\Omega$      |
| Forward Transconductance <sup>a</sup>                                    | $g_{fs}$                    | $V_{DS} = 50\text{ V}, I_D = 13\text{ A}$   |   | -    | 9.4   | -         | S             |
| <b>Dynamic</b>   |                             |   |   |      |       |           |               |
| Input Capacitance  | $C_{iss}$                   | $V_{GS} = 0\text{ V},$<br>$V_{DS} = 25\text{ V},$<br>$f = 1.0\text{ MHz}$                             |   | -    | 2810  | -         | pF            |
| Output Capacitance   | $C_{oss}$                   |   |   | -    | 1480  | -         |               |
| Reverse Transfer Capacitance   | $C_{rss}$                   |   |   | -    | 33    | -         |               |
| Effective Output Capacitance (Time Related)                              | $C_{oss\text{ eff.}}(TR)^a$ | $V_{GS} = 0\text{ V}$   | $V_{DS} = 0\text{ V to } 480\text{ V}$  | -    | 155   | -         |               |
| Total Gate Charge  | $Q_g$                       | $V_{GS} = 10\text{ V}$  | $I_D = 22\text{ A}, V_{DS} = 480\text{ V}$  | -    | 75    | 110       | nC            |
| Gate-Source Charge   | $Q_{gs}$                    |   |   | -    | 17    | -         |               |
| Gate-Drain Charge  | $Q_{gd}$                    |   |   | -    | 25    | -         |               |
| Turn-On Delay Time   | $t_{d(on)}$                 | $V_{DD} = 380\text{ V}, I_D = 22\text{ A},$<br>$R_g = 9.1\text{ }\Omega, V_{GS} = 10\text{ V}$        |   | -    | 24    | 50        | ns            |
| Rise Time  | $t_r$                       |   |   | -    | 68    | 100       |               |
| Turn-Off Delay Time  | $t_{d(off)}$                |   |   | -    | 77    | 115       |               |
| Fall Time  | $t_f$                       |   |   | -    | 59    | 90        |               |
| Gate Input Resistance  | $R_g$                       | $f = 1\text{ MHz}, \text{ open drain}$  |   | -    | 0.65  | -         | $\Omega$      |
| <b>Drain-Source Body Diode Characteristics</b>                           |                             |   |   |      |       |           |               |
| Continuous Source-Drain Diode Current                                    | $I_S$                       | MOSFET symbol showing the integral reverse p - n junction diode                                       |  | -    | -     | 22        | A             |
| Pulsed Diode Forward Current   | $I_{SM}$                    |   |   | -    | -     | 88        |               |
| Diode Forward Voltage  | $V_{SD}$                    | $T_J = 25\text{ }^\circ\text{C}, I_S = 22\text{ A}, V_{GS} = 0\text{ V}$                              |   | -    | -     | 1.2       | V             |
| Reverse Recovery Time  | $t_{rr}$                    | $T_J = 25\text{ }^\circ\text{C}, I_F = I_S,$<br>$di/dt = 100\text{ A}/\mu\text{s}, V_R = 25\text{ V}$ |   | -    | 462   | 690       | ns            |
| Reverse Recovery Charge  | $Q_{rr}$                    |   |   | -    | 8.3   | 16        | $\mu\text{C}$ |
| Reverse Recovery Current   | $I_{RRM}$                   |   |   | -    | 30    | 60        | A             |

**Note**

a.  $C_{oss\text{ eff.}}(TR)$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

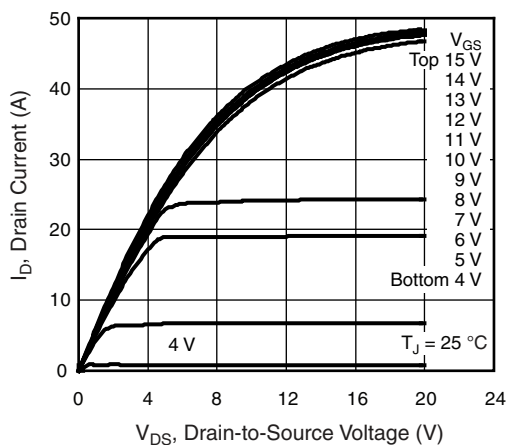


Fig. 1 - Typical Output Characteristics,  $T_J = 25\text{ }^\circ\text{C}$

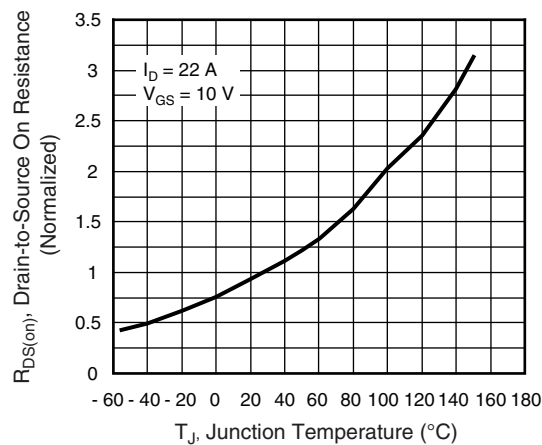


Fig. 4 - Normalized On-Resistance vs. Temperature

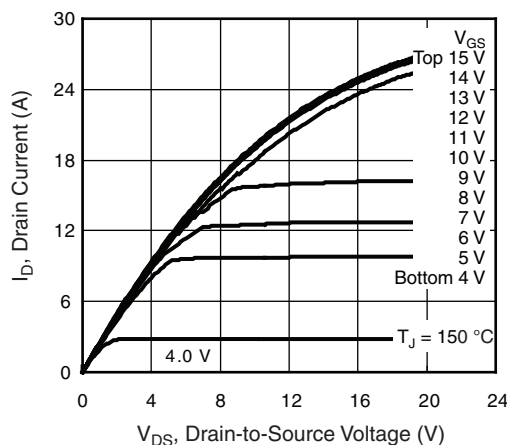


Fig. 2 - Typical Output Characteristics,  $T_J = 150\text{ }^\circ\text{C}$

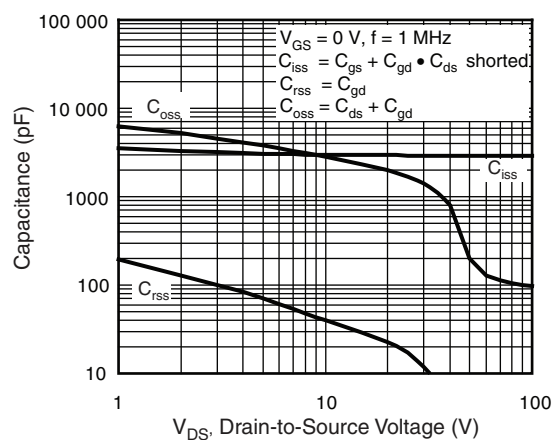


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

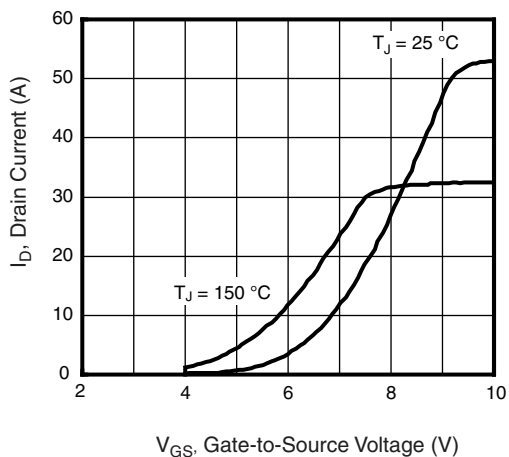


Fig. 3 - Typical Transfer Characteristics

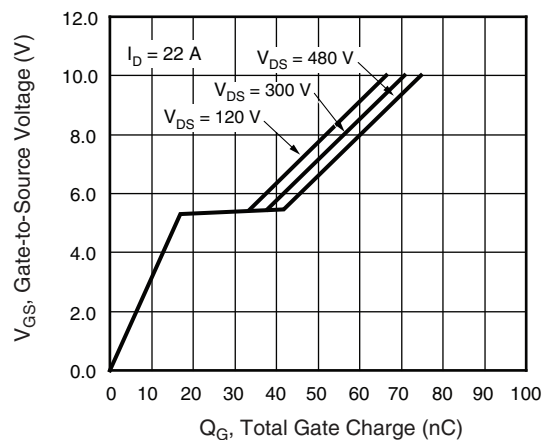


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

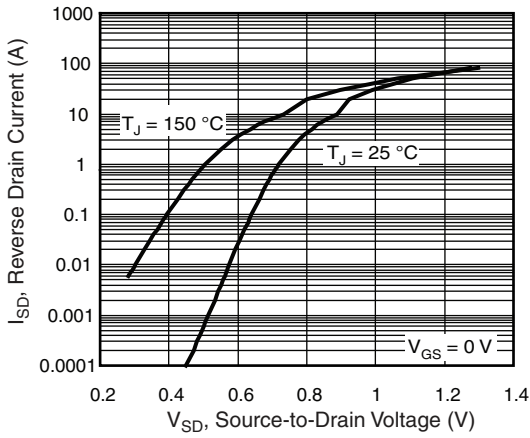


Fig. 7 - Typical Source-Drain Diode Forward Voltage

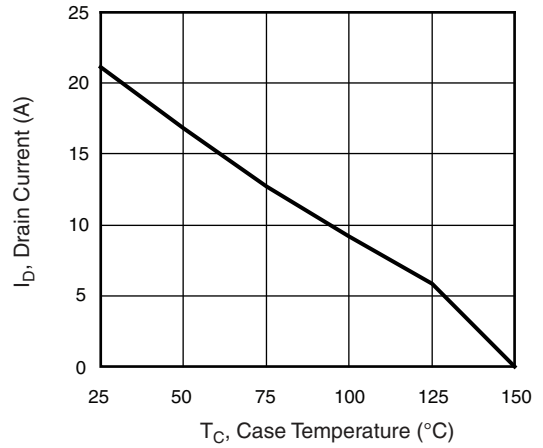


Fig. 9 - Maximum Drain Current vs. Case Temperature

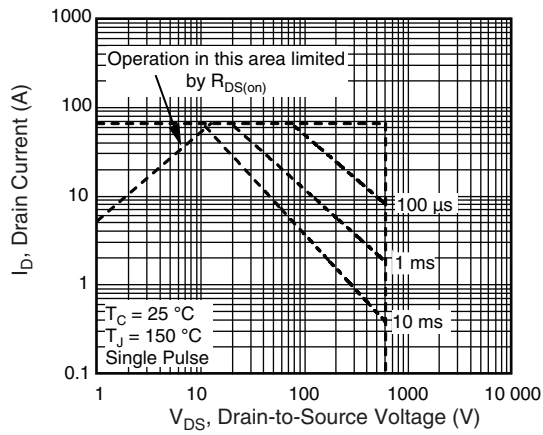


Fig. 8 - Maximum Safe Operating Area

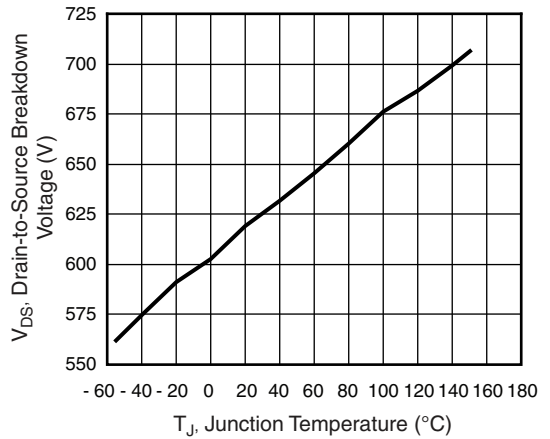


Fig. 10 - Drain-to-Source Breakdown Voltage

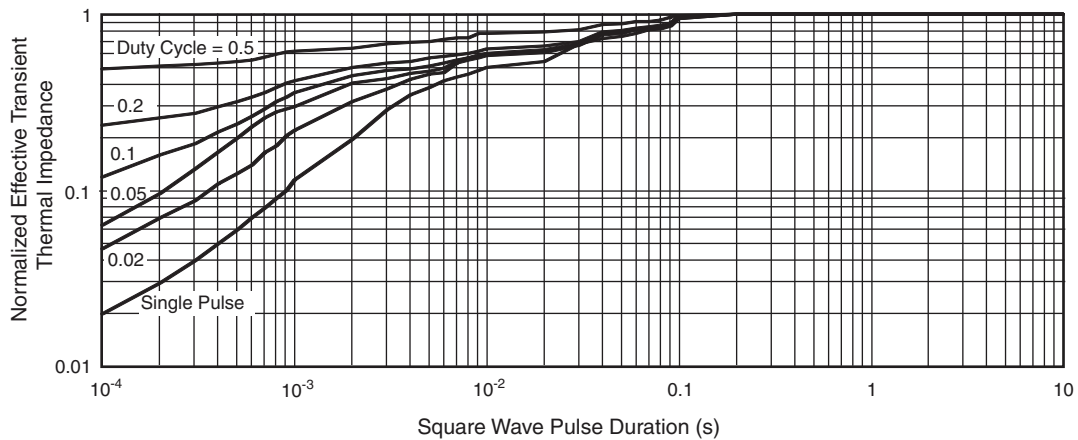


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

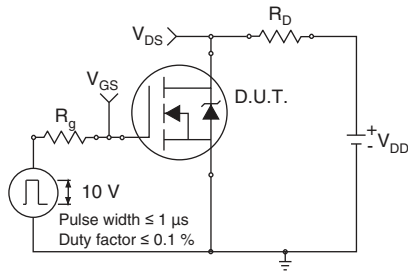


Fig. 12 - Switching Time Test Circuit

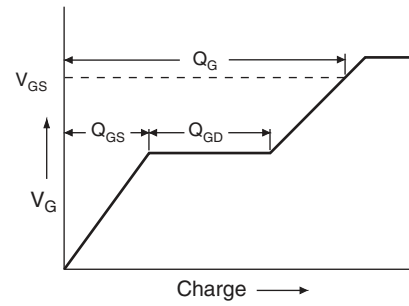


Fig. 16 - Basic Gate Charge Waveform

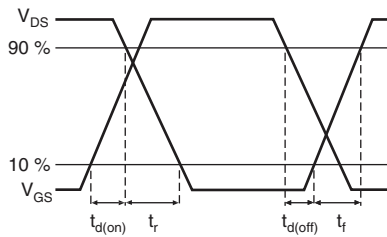


Fig. 13 - Switching Time Waveforms

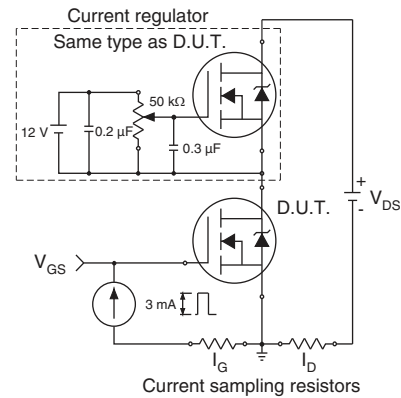


Fig. 17 - Gate Charge Test Circuit

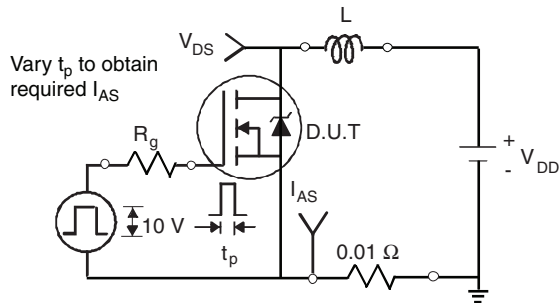


Fig. 14 - Unclamped Inductive Test Circuit

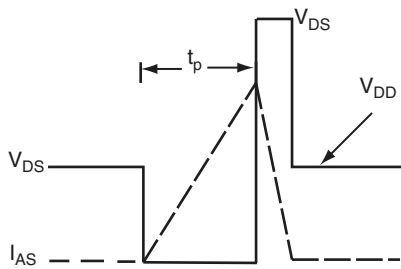
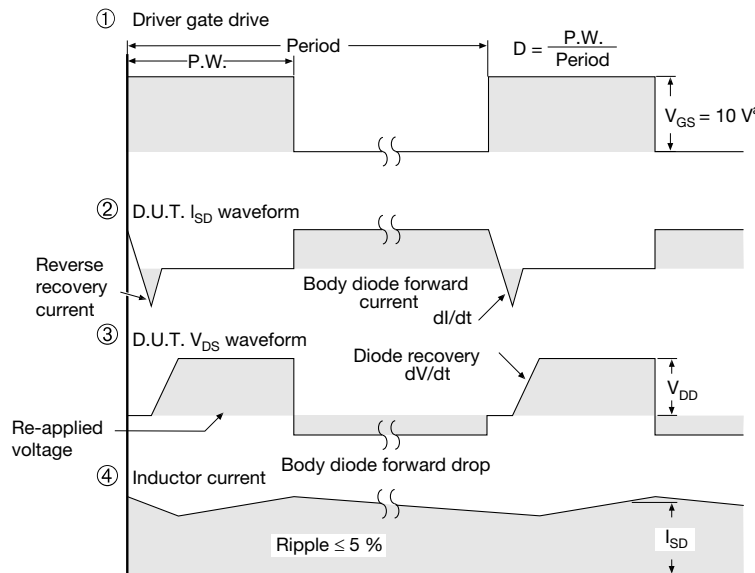
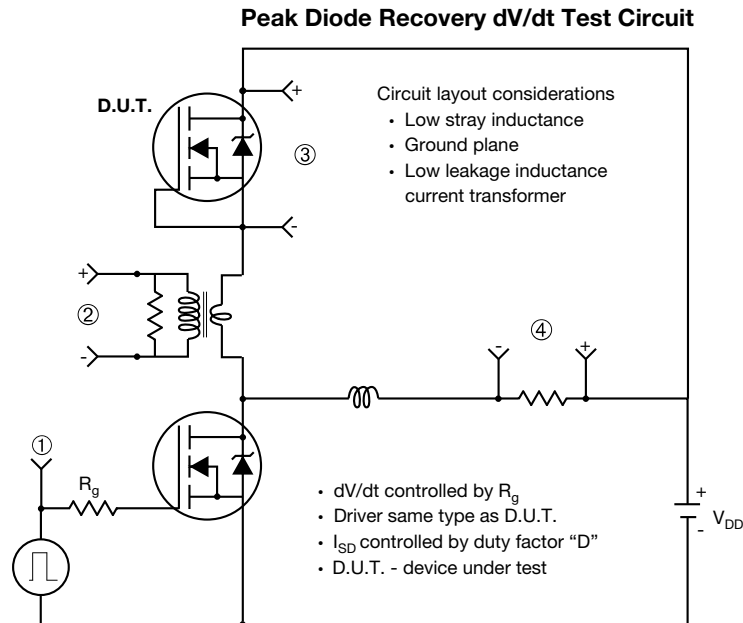


Fig. 15 - Unclamped Inductive Waveforms



**Note**

a.  $V_{GS} = 5\text{ V}$  for logic level devices

**Fig. 18 - For N-Channel**

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